## Serially Interfaced, 8-Digit LED Driver

## 1 General Description

The AS1100 is an LED driver for 7 segment numeric displays of up to 8 digits. The AS1100 can be programmed via a conventional 4 wire serial interface.
The device includes a BCD code-B decoder, a multiplex scan circuitry, segment and display drivers, and a 64 Bit memory. The memory is used to store the LED settings, so that continuous reprogramming is not necessary.
Every individual segment can be addressed and updated separately. Only one external resistor is required to set the current through the LED display. Brightness can be controlled either in an analog or digital way. The user can choose the internal code-B decoder to display numeric digits or to address each segment directly.
The AS1100 features an extremely low shutdown current of only $20 \mu \mathrm{~A}$ and an operational current of less than $500 \mu \mathrm{~A}$. The number of visible digits can be programmed as well. The AS1100 can be reset by software and an external clock can be used. Several test modes support easy debugging.
The AS1100 is offered in a 24 -pin DIP and SOIC packages.

## 2 Key Features

- 10 MHz Serial Interface
- Individual LED Segment Control
- Decode/No-Decode Digit Selection
- 20 AA Low-Power Shutdown (Data Retained)
- Extremely low Operating Current 0.5 mA in open loop
- Digital and Analog Brightness Control
- Display Blanked on Power-Up
- Drive Common-Cathode LED Display
- Software Reset
- Optional External clock
- 24-pin DIP and SOIC Packages


## 3 Applications

The AS1100 is an ideal solution for Bar-Graph Displays, Industrial Controllers, Panel Meters, LED Matrix Displays and White Goods such as washing machines and dishwasher.

Figure 1. Typical Application Diagram - Single Cell to 3.3V Synchronous Boost Converter


## 4 Pin Assignments

Figure 2. Pin Assignments (Top View)


## Pin Descriptions

Table 1. Pin Descriptions

| Pin <br> Name | Pin <br> Number | Description |
| :---: | :---: | :--- |
| DIN | 1 | Data input. Data is programmed into the 16Bit shift register on the rising <br> CLK edge |
| DIG 0 - DIG 7 | $2,3,5-8$, <br> 10,11 | 8 digit driver lines that sink the current from the common cathode of the <br> display. In shutdown mode the AS1100 switches the outputs to VDD. |
| GND | 4,9 | Both GND pins must be connected. |
| LOAD/CS | 12 | Strobe input. With the rising edge of the LOAD signal the 16 bit of serial <br> data is latched into the register. |
| CLK | 13 | Clock input. The interface is capable to support clock frequencies up to <br> loMHz. The serial data is clocked into the internal shift register with the <br> rising edge of the CLK signal. On the DOUT pin the data is applied with the <br> falling edge of CLK. |
| SEG A-G, DP | $14-17$, | Seven segment driver lines including the decimal point. When a <br> segment is turned off the output is connected to GND. |
| ISET | 18 | The current into ISET determines the peak current through the segments <br> and therefore the brightness. |
| VDD | 19 | Positive Supply Voltage (+5V) <br> DOUT |
| Serial data output for cascading drivers. The output is valid after 16.5 |  |  |
| clock cycles. The output is never set to high impedance. |  |  |

## 5 Absolute Maximum Ratings

Table 2. Absolute Maximum Ratings

| Parameter | Min | Max | Units | Notes |
| :---: | :---: | :---: | :---: | :---: |
| VDD to GND | -0.3 | +6 | V |  |
| DIN, CLK, LOAD to GND | -0.3 | +6 | V |  |
| All other Pins to GND | -0.3 | VDD +0.3 | V |  |
| Vout | -0.3 | 7 | V |  |
| Electro Static Discharge at Digital <br> Outputs | +500 | V |  |  |
| Electro Static Discharge at all other pins | +1000 | V |  |  |

## Current

| DIG0-DIG7 Sink Current | 500 | mA |  |
| :---: | :---: | :---: | :---: |
| SEGA-G, DP Source Current | 100 | mA |  |
| Latch up Immunity | $\pm 200$ | mA |  |
| Continuous Power Dissipation (TA $=+85^{\circ} \mathrm{C}$ ) |  |  |  |
| Narrow Plastic DIP | 1066 | mW | Derate $13.3 \mathrm{~mW} /{ }^{\circ} \mathrm{C}$ above $+70^{\circ} \mathrm{C}$ |
| Wide SO | 941 | mW | Derate $11.8 \mathrm{~mW} /{ }^{\circ} \mathrm{C}$ above $+70^{\circ} \mathrm{C}$ |
| Operating Temperature Ranges (TMIN to TMAX) |  |  |  |
| AS1100xL | 0 +70 | ${ }^{\circ} \mathrm{C}$ |  |
| AS1100xE | -40 +85 | ${ }^{\circ} \mathrm{C}$ |  |
| Storage Temperature Range | -65 | ${ }^{\circ} \mathrm{C}$ |  |
| Package Body Temperature | +260 | ${ }^{\circ} \mathrm{C}$ | The reflow peak soldering temperature (body temperature) specified is in accordance with IPC/JEDEC J-STD020C "Moisture/Reflow Sensitivity Classification for Non-Hermetic Solid State Surface Mount Devices". The lead finish for Pb-free leaded packages is matte tin $(100 \% \mathrm{Sn})$. |

## 6 Electrical Characteristics

VDD $=5 \mathrm{~V}$, Rset $=9.53 \mathrm{k} \Omega \pm 1 \%, \mathrm{~T}_{\mathrm{A}}=$ Tmin to Tmax, unlesss otherwise noted.
Table 3. Electrical Characteristics

| Symbol | Parameter | Conditions | Min | Typ | Max | Units |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| VDD | Operating Supply Voltage |  | 4.0 | 5.0 | 5.5 | V |
| IDDSD | Shutdown Supply Current | All digital inputs at VDD or GND, $\mathrm{TA}=+25^{\circ} \mathrm{C}$ |  | 20 | 50 | $\mu \mathrm{A}$ |
| IDD | Operating Supply Current | RSET = open circuit |  |  | 500 | $\mu \mathrm{A}$ |
|  |  | All segments and decimal point on, $\mathrm{I}_{\mathrm{SEG}}=-40 \mathrm{~mA}$ |  | 330 |  | mA |
| fosc | Display Scan Rate | 8 digits scanned | 500 | 800 | 1300 | Hz |
| IDIGIT | Digit Drive Sink Current | Vout $=0.65 \mathrm{~V}$ | 320 |  |  | mA |
| ISEG | Segment Drive Source Current | $\mathrm{T}_{\mathrm{A}}=+25^{\circ} \mathrm{C}, \mathrm{Vout}=($ VDD $-1 \mathrm{~V})$ | -30 | -40 | -45 | mA |
| $\Delta{ }^{\text {S SEG }}$ | Segment Drive Current Matching |  |  | 3.0 |  | \% |
| IDIGIT | Digit Drive Source Current | Digit off, VDIGIT $=(\mathrm{VDD}-0.3 \mathrm{~V})$ | -2 |  |  | mA |
| ISEG | Segment Drive Sink Current | Segment off, Vseg $=0.3 \mathrm{~V}$ | 5 |  |  | mA |
| Logic Inputs |  |  |  |  |  |  |
| $\mathrm{IIH}^{\text {I }}$ IL | Input Current DIN, CLK, LOAD | VIN $=0 \mathrm{~V}$ or VDD | -1 |  | 1 | $\mu \mathrm{A}$ |
| $\mathrm{V}_{\mathrm{IH}}$ | Logic High Input Voltage |  | 3.5 |  |  | V |
| $\mathrm{V}_{\text {IL }}$ | Logic Low Input Voltage |  |  |  | 0.8 | V |
| $\mathrm{V}_{\mathrm{OH}}$ | Output High Voltage | DOUT, ISOURCE $=-1 \mathrm{~mA}$ | Vdd - 1 |  |  | V |
| $\mathrm{V}_{\mathrm{OL}}$ | Output Low Voltage | DOUT, IsInk $=1.6 \mathrm{~mA}$ |  |  | 0.4 | V |
|  | Hysteresis Voltage | DIN, CLK, LOAD |  | 1 |  | V |
| Timing Characteristics |  |  |  |  |  |  |
| $\mathrm{t}_{\mathrm{CP}}$ | CLK Clock Period |  | 100 |  |  | ns |
| $\mathrm{t}_{\mathrm{CH}}$ | CLK Pulse Width High |  | 50 |  |  | ns |
| $\mathrm{t}_{\mathrm{CL}}$ | CLK Pulse Width Low |  | 50 |  |  | ns |
| $\mathrm{t}_{\text {CSH }}$ | CLK Rise to LOAD Rise Hold Time |  | 0 |  |  | ns |
| $t_{\text {DS }}$ | DIN Setup Time |  | 25 |  |  | ns |
| $t_{\text {DH }}$ | DIN Hold Time |  | 0 |  |  | ns |
| tDO | Output Data Propagation Delay | $C_{\text {LOAD }}=50 \mathrm{pF}$ |  |  | 25 | ns |
| tıDCK | LOAD Rising Edge to Next Clock Rising Edge |  | 50 |  |  | ns |
| tcsw | Minimum LOAD Pulse High |  | 50 |  |  | ns |
| $t_{\text {DSPD }}$ | Data-to-Segment Delay |  |  |  | 2.25 | ms |

## 7 Typical Operating Characteristics

Figure 3. Segment Driver Capability, VDD $=5 \mathrm{~V}$, Logic Level $=$ High


Figure 4. Segment Current versa RsET


## 8 Detailed Description

## Serial-Addressing Modes

Programming of the AS1100 is done via 4 wire serial interface. A programming sequence consists of 16 -bit packages. The data is shifted into the internal 16 Bit register with the rising edge of the CLK signal. With the rising edge of the LOAD signal the data is latched into a digital or control register depending on the address. The LOAD signal must go to high after the 16th rising clock edge. The LOAD signal can also come later but just before the next rising edge of CLK, otherwise data would be lost. The content of the internal shift register is applied 16.5 clock cycles later to the DOUT pin. The data is clocked out at the falling edge of CLK. The Bits of the 16Bit-programming package are described in Table 4. The first 4 Bits D15-D12 are don't care, D11-D8 contain the address and D7-D0 contain the data. The first bit is D15, the most significant bit (MSB). The exact timing is given in Figure 5.

Figure 5. Timing Diagram


Table 4. Serial data format (16bits)

| D15 | D14 | D13 | D12 | D11 | D10 | D9 | D8 | D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| X | X | X | X | Address |  |  |  | MSB |  |  | Data |  |  |  | LSB |

## Digit and Control Registers

The AS1100 incorporates 15 registers, which are listed in Table 5. The digit and control registers are selected via the 4Bit address word. The 8 digit registers are realized with a 64bit memory. Each digit can be controlled directly without rewriting the whole contents. The control registers consist of decode mode, display intensity, number of scanned digits, shutdown, display test, and reset/external clock register.

## Shutdown Mode

The AS1100 features a shutdown mode, where it consumes only $20 \mu \mathrm{~A}$ current. The shutdown mode is entered via a write to register 0 Ch . Then all segment current sources are pulled to ground and all digit drivers are connected to VdD, so that nothing is displayed. All internal digit registers keep the programmed values. The shutdown mode can either be used for power saving or for generating a flashing display by repeatedly entering and leaving the shutdown mode. The AS1100 needs typically $250 \mu$ s to exit the shutdown mode. During shutdown the AS1100 is fully programmable. Only the display test function overrides the shutdown mode.

## Initial Power-Up

After powering up the system all register are reset, so that the display is blank. The AS1100 starts the shutdown mode. All registers should be programmed for normal operation. The default settings enable only scan of one digit, the internal decoder is disabled, data register and intensity register are set to the minimum value.

## Decode-Mode Register

In the AS1100 a BCD decoder is included. Every digit can be selected via register 09h to be decoded. The BCD code consists of the numbers $0-9, \mathrm{E}, \mathrm{H}, \mathrm{L}, \mathrm{P}$ and -. In register 09h a logic high enables the decoder for the appropriate digit. In case that the decoder is bypassed (logic low) the data Bits D7-D0 correspond to the segment lines of the AS1100. In Table 7 some possible settings for register 09h are shown. Bit D7, which corresponds to the decimal point, is not affected by the settings of the decoder. Logic high means that the decimal point is displayed. In Table 8 the font of the Code B decoder is shown. In Table 9 the correspondence of the register to the appropriate segments of a 7 segment display is shown (see Figure 6).

## Intensity Control and Interdigit Blanking

Brightness of the display can be controlled in an analog way by changing the external resistor (RSET). The current, which flows between VDD and ISET, defines the current that flows through the LEDs. The LED current is 100 times the ISET current. The minimum value of RsET should be $9.53 \mathrm{k} \Omega$, which corresponds to 40 mA segment current. The brightness of the display can also be controlled digitally via register OAh. The brightness can be programmed in 16 steps and is shown in Table 10. An internal pulse width modulator controls the intensity of the display.

## Scan-Limit Register

The scan limit register OBh selects the number of digits displayed. When all 8 digits are displayed the update frequency is typically 800 Hz . If the number of digits displayed is reduced, the update frequency is reduced as well. The frequency can be calculated using $8 f O S C / N$, where $N$ is the number of digits. Since the number of displayed digits influences the brightness, the resistor RSET should be adjusted accordingly. The Table 12 shows the maximum allowed current, when fewer than 4 digits are used. To avoid differences in brightness the scan limit register should not be used to blank portions of the display (leading zeros).

Table 5. Register address map

| Register | Address |  |  |  |  | Hex <br> Code |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  | D15-D12 | D11 | D10 | D9 | D8 |  |
| No-Op | X | 0 | 0 | 0 | 0 | 0xX0 |
| Digit 0 | $X$ | 0 | 0 | 0 | 1 | 0xX1 |
| Digit 1 | X | 0 | 0 | 1 | 0 | 0xX2 |
| Digit 2 | X | 0 | 0 | 1 | 1 | 0xX3 |
| Digit 3 | $x$ | 0 | 1 | 0 | 0 | 0xX4 |
| Digit 4 | X | 0 | 1 | 0 | 1 | 0xX5 |
| Digit 5 | X | 0 | 1 | 1 | 0 | 0xX6 |
| Digit 6 | $x$ | 0 | 1 | 1 | 1 | 0xX7 |
| Digit 7 | X | 1 | 0 | 0 | 0 | 0xX8 |
| Decode Mode | X | 1 | 0 | 0 | 1 | 0xX9 |
| Intensity | X | 1 | 0 | 1 | 0 | 0xXA |
| Scan Limit | X | 1 | 0 | 1 | 1 | 0xXB |
| Shutdown | X | 1 | 1 | 0 | 0 | 0xXC |
| Not used | X | 1 | 1 | 0 | 1 | 0xXD |
| Reset and ext. Clock | X | 1 | 1 | 1 | 0 | 0xXE |
| Display Test | X | 1 | 1 | 1 | 1 | 0xXF |

Table 6. Shutdown Register Format (address (hex) $=0 \times X C$

| Mode | Address Code |  |  |  |  |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  | D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 |  |
| Shutdown Mode | $0 \times X C$ | X | X | X | X | X | X | X | 0 |
| Normal Operation | 0xXC | X | X | X | X | X | X | X | 1 |

Table 7. Decode-mode Register Examples (address (hex) = 0xX9

| Decode Mode | Register Data |  |  |  |  |  |  |  | D3 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  | D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 | Hex Code |
| No decode for digits 7-0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | $0 \times 00$ |
| Code B decode for digit 0 <br> No decode for digits 7-1 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 1 | $0 \times 01$ |
| Code B decode for digits 3-0 <br> No decode for digits 7-4 | 0 | 0 | 0 | 0 | 1 | 1 | 1 | 1 | $0 \times 0 F$ |
| Code B decode for digits 7-0 | 1 | 1 | 1 | 1 | 1 | 1 | 1 | 1 | $0 x F F$ |

Table 8. Code B font

| 7-Segment Character | Register Data |  |  |  |  |  | On Segments = 1 |  |  |  |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  | D7* | D6-D4 | D3 | D2 | D1 | D0 | DP* | A | B | C | D | E | F | G |
| 0 |  | X | 0 | 0 | 0 | 0 |  | 1 | 1 | 1 | 1 | 1 | 1 | 0 |
| 1 |  | X | 0 | 0 | 0 | 1 |  | 0 | 1 | 1 | 0 | 0 | 0 | 0 |
| 2 |  | X | 0 | 0 | 1 | 0 |  | 1 | 1 | 0 | 1 | 1 | 0 | 1 |
| 3 |  | X | 0 | 0 | 1 | 1 |  | 1 | 1 | 1 | 1 | 0 | 0 | 1 |
| 4 |  | X | 0 | 1 | 0 | 0 |  | 0 | 1 | 1 | 0 | 0 | 1 | 1 |
| 5 |  | X | 0 | 1 | 0 | 1 |  | 1 | 0 | 1 | 1 | 0 | 1 | 1 |
| 6 |  | X | 0 | 1 | 1 | 0 |  | 1 | 0 | 1 | 1 | 1 | 1 | 1 |
| 7 |  | X | 0 | 1 | 1 | 1 |  | 1 | 1 | 1 | 0 | 0 | 0 | 0 |
| 8 |  | X | 1 | 0 | 0 | 0 |  | 1 | 1 | 1 | 1 | 1 | 1 | 1 |
| 9 |  | X | 1 | 0 | 0 | 1 |  | 1 | 1 | 1 | 1 | 0 | 1 | 1 |
| -- |  | X | 1 | 0 | 1 | 0 |  | 0 | 0 | 0 | 0 | 0 | 0 | 1 |
| E |  | X | 1 | 0 | 1 | 1 |  | 1 | 0 | 0 | 1 | 1 | 1 | 1 |
| H |  | X | 1 | 1 | 0 | 0 |  | 0 | 1 | 1 | 0 | 1 | 1 | 1 |
| L |  | X | 1 | 1 | 0 | 1 |  | 0 | 0 | 0 | 1 | 1 | 1 | 0 |
| P |  | X | 1 | 1 | 1 | 0 |  | 1 | 1 | 0 | 0 | 1 | 1 | 1 |
| blank |  | X | 1 | 1 | 1 | 1 |  | 0 | 0 | 0 | 0 | 0 | 0 | 0 |

Note: The decimal point is set by bit D7 = 1
Table 9. No-decode mode data bits and corresponding segment lines

|  | Register Data | D | D | D | D1 | D0 |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Corresponding Segment Line | DP | A | B | C | D | E | F | G |

Figure 6. Standard 7-segment LED
$\square$
Table 10. Intensity register format (address (hex) $=0 \times X A$ )

| Duty Cycle | D7 | D6 | D5 | D4 | D3 | D2 | D1 | DO | Hex Code |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 1/32 (min on) | X | X | X | X | 0 | 0 | 0 | 0 | $0 \times X 0$ |
| 3/32 | X | X | X | X | 0 | 0 | 0 | 1 | 0xX1 |
| 5/32 | X | X | X | X | 0 | 0 | 1 | 0 | 0xX2 |
| 7/32 | X | X | X | X | 0 | 0 | 1 | 1 | 0xX3 |
| 9/32 | X | X | X | X | 0 | 1 | 0 | 0 | 0xX4 |
| 11/32 | X | X | X | X | 0 | 1 | 0 | 1 | 0xX5 |
| 13/32 | X | X | X | X | 0 | 1 | 1 | 0 | 0xX6 |
| 15/32 | X | X | X | X | 0 | 1 | 1 | 1 | 0xX7 |
| 17/32 | X | X | X | X | 1 | 0 | 0 | 0 | $0 \times \mathrm{X8}$ |
| 19/32 | x | X | X | X | 1 | 0 | 0 | 1 | 0xX9 |
| 21/32 | X | X | X | X | 1 | 0 | 1 | 0 | $0 \times X A$ |
| 23/32 | X | X | X | X | 1 | 0 | 1 | 1 | 0xXB |
| 25/32 | X | X | X | X | 1 | 1 | 0 | 0 | 0xXC |
| 27/32 | X | X | X | X | 1 | 1 | 0 | 1 | 0xXD |
| 29/32 | X | X | X | X | 1 | 1 | 1 | 0 | 0xXE |
| 31/32 (max on) | X | X | X | X | 1 | 1 | 1 | 1 | 0xXF |

Table 11. Scan -limit register format (address (hex) $=0 \times X B$ )

| Decode Mode | Register Data |  |  |  |  |  |  |  | Hex Code |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  | D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 |  |
| Display digit 0 only | X | X | X | X | X | 0 | 0 | 0 | 0xX0 |
| Display digit 0 \& 1 | X | X | X | X | X | 0 | 0 | 1 | $0 \times \mathrm{X1}$ |
| Display digit 012 | X | X | X | X | X | 0 | 1 | 0 | $0 \times \times 2$ |
| Display digit 0123 | X | X | X | X | X | 0 | 1 | 1 | $0 \times X 3$ |
| Display digit 01234 | X | X | X | X | X | 1 | 0 | 0 | $0 \times \times 4$ |
| Display digit 012345 | X | X | X | X | X | 1 | 0 | 1 | 0xX5 |
| Display digit 0123456 | X | X | X | X | X | 1 | 1 | 0 | 0xX6 |
| Display digit 01234567 | X | X | X | X | X | 1 | 1 | 1 | 0xX7 |

## Display Test Register

With the display test register OFh all LED can be tested. In the test mode all LEDs are switched on at maximum brightness (duty cycle 31/32). All programming of digit and control registers are maintained. The format of the register is given in Table 13.

Table 12. Maximum segment current for 1-, 2-, or 3-digit displays

| Number of digits Displayed | Maximum Segment Current (mA) |
| :---: | :---: |
| 1 | 10 |
| 2 | 20 |
| 3 | 30 |

Table 13. Display-test register format (address (hex) $=0 \times X F$ )

| Mode | Register Data |  |  |  |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  | D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 |
| Normal Operation | X | X | X | X | X | X | X | 0 |
| Display Test Mode | X | X | X | X | X | X | X | 1 |

Note: The AS1100 remains in display-test mode until the display-test register is reconfigured for normal operation.

## No-Op Register (Cascading of AS1100)

The no-operation register 00h is used when AS1100s are cascaded in order to support more than 8 digit displays. The cascading must be done in a way that all DOUT are connected to DINof the following AS1100. The LOAD and CLK signals are connected to all devices. For a write operation for example to the fifth device the command must be followed by four no-operation commands. When the LOAD signal finally goes to high all shift registers are latched. The first four devices have got no-operation commands and only the fifth device sees the intended command and updates its register.

## Reset and external Clock Register

This register is addressed via the serial interface. It allows to switch the device to external clock mode (If D0=1 the CLK pin of the serial interface operates as system clock input.) and to apply an external reset (D1). This brings all registers (except reg. E) to default state. For standard operation the register contents should be "OOh".

Table 14. Reset and External Clock Register (address (hex) = oxXE)

| Mode | Address |  |  |  |  |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  | code (Hex) | D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 |
| Normal Operation, <br> internal clock | $0 \times X E$ | $X$ | $X$ | $X$ | $X$ | $X$ | $X$ | 0 | 0 |
| Normal Operation, <br> external clock | $0 \times X E$ | $X$ | $X$ | $X$ | $X$ | $X$ | $X$ | 0 | 1 |
| Reset state, <br> internal clock | 0xXE | $X$ | $X$ | $X$ | $X$ | $X$ | $X$ | 1 | 0 |
| Reset state, <br> external clock | $0 \times X E$ | $X$ | $X$ | $X$ | $X$ | $X$ | $X$ | 1 | 1 |

## 9 Application Information

## Supply Bypassing and Wiring

In order to achieve optimal performance the AS1100 shall be placed very close to the LED display to minimize effects of electromagnetic interference and wiring inductance. Furthermore, it is recommended to connect a $10 \mu \mathrm{~F}$ electrolytic and a $0.1 \mu \mathrm{~F}$ ceramic capacitor between VDD and GND to avoid power supply ripple. Also, both GNDs must be connected to ground.

## Selecting Rset Resistor and Using External Drivers

The current through the segments is controlled via the external resistor Rset. Segment current is about 100 times the current in ISET. The right values for ISET are given in Table 15. The maximum current the AS1100 can drive is 40 mA . If higher currents are needed, external drivers must be used. In that case it is no longer necessary that the AS1100 drives high currents. A recommended value for RSET is $47 \mathrm{k} \Omega$. In cases that the AS1100 only drives few digits, Table 12 specifies the maximum currents and RsET must be set accordingly. Refer to absolute maximum ratings to calculate acceptable limits for ambient temperature, segment current, and the LED forward-voltage drop.

Table 15. RSET vs segment current and LED forward voltage

| ISEG (mA) | $\operatorname{VLED}(\mathrm{V})$ |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: |
|  | $\mathbf{1 . 5}$ | $\mathbf{2 . 0}$ | $\mathbf{2 . 5}$ | $\mathbf{3 . 0}$ | $\mathbf{3 . 5}$ |
| 40 | $12.2 \mathrm{k} \Omega$ | $11.8 \mathrm{k} \Omega$ | $11.0 \mathrm{k} \Omega$ | $10.6 \mathrm{k} \Omega$ | $9.69 \mathrm{k} \Omega$ |
| 30 | $17.8 \mathrm{k} \Omega$ | $17.1 \mathrm{k} \Omega$ | $15.8 \mathrm{k} \Omega$ | $15.0 \mathrm{k} \Omega$ | $14.0 \mathrm{k} \Omega$ |
| 20 | $29.8 \mathrm{k} \Omega$ | $28.0 \mathrm{k} \Omega$ | $25.9 \mathrm{k} \Omega$ | $24.5 \mathrm{k} \Omega$ | $22.6 \mathrm{k} \Omega$ |
| 10 | $66.7 \mathrm{k} \Omega$ | $63.7 \mathrm{k} \Omega$ | $59.3 \mathrm{k} \Omega$ | $55.4 \mathrm{k} \Omega$ | $51.2 \mathrm{k} \Omega$ |

## 8x8 LED Dot Matrix Driver

The example in Figure 7 uses the AS1100 to drive an $8 \times 8$ LED dot matrix. The LED columns have common cathode and are connected to the DIG0-7 outputs. The rows are connected to the segment drivers. Each of the 64 LEDs can be addressed separately. The columns are selected via the digits as shown in Table 5. The decode mode register (0xX9) has to be programmed to ' 00000000 ' as stated in Table 4. The single LEDs in a column can be addressed as stated in Table 9, where D0 corresponds to segment $G$ and d/ to segment DP. For a multiple digit dot matrix several AS1100 have to be cascaded.

Figure 7. Application example as LED dot matrix driver


## Cascading Drivers

The AS1100 can be cascaded as well. The DOUT pin must be connected to the DIN pin of the following AS1100.

Table 16. Package thermal resistance data

| Package | Thermal Resistance $\left(\theta_{\mathrm{JA}}\right)$ |
| :---: | :---: |
| 24 Narrow DIP | $+75^{\circ} \mathrm{C} / \mathrm{W}$ |
| 24 Wide SO | $+85^{\circ} \mathrm{C} / \mathrm{w}$ |
| Maximum Junction Temperature $\left(T_{J}\right)=+150^{\circ} \mathrm{C}$ |  |
| Maximum Ambient Temperature $\left(\mathrm{T}_{\mathrm{A}}\right)=+85^{\circ} \mathrm{C}$ |  |

## Computing Power Dissipation

The upper limit for power dissipation (PD) for the AS1100 is determined from the following equation:

$$
\begin{equation*}
P D=(V D D \times 0.5 m A)+(V D D-V L E D)(D U T Y \times I S E G \times N) \tag{EQ1}
\end{equation*}
$$

## Where:

VDD = supply voltage
DUTY = duty cycle set by intensity register
$\mathrm{N}=$ number of segments driven (worst case is 8 )
VLED = LED forward voltage
ISEG = segment current set by RSET

Dissipation Example:
Iseg $=40 \mathrm{~mA}, \mathrm{~N}=8$, DUTY $=31 / 32, \mathrm{VLED}=1.8 \mathrm{~V}$ at $40 \mathrm{~mA}, \mathrm{VDD}=5.25 \mathrm{~V}$
$\mathrm{PD}=5.25 \mathrm{~V}(0.5 \mathrm{~mA})+(5.25 \mathrm{~V}-1.8 \mathrm{~V})(31 / 32 \times 40 \mathrm{~mA} \times 8)=1.07 \mathrm{~W}$
Thus, for a PDIP package $\theta_{\mathrm{JA}}=+75^{\circ} \mathrm{C} / \mathrm{W}$ (from Table 13), the maximum allowed ambient temperature $\mathrm{T}_{\mathrm{A}}$ is given by:
$T_{J, M A X}=T_{A}+P D \times \theta_{J A}=150^{\circ} \mathrm{C}=T_{A}+1.07 \mathrm{~W} \times 75^{\circ} \mathrm{C} / \mathrm{W}$.
Where:
$\mathrm{T}_{\mathrm{A}}=+69.7^{\circ} \mathrm{C}$.
The $\mathrm{T}_{\mathrm{A}}$ limit for SO Packages in the dissipation example above is $+59.0^{\circ} \mathrm{C}$.

## 10 Package Drawings and Markings

The device is available in a SOIC-24 package and PDIP-24 package .
Figure 8. SOIC-24 package Diagram


Table 17. SOIC-24 package Dimensions

| Symbol | Min | Max | Symbol | Min | Max |
| :---: | :---: | :---: | :---: | :---: | :---: |
| A | 2.44 | 2.64 | H | 10.11 | 10.51 |
| A1 | 0.10 | 0.30 | h | 0.31 | 0.71 |
| A2 | 2.24 | 2.44 | J | 0.53 | 0.73 |
| B | 0.36 | 0.46 | K | $7^{\circ} \mathrm{BSC}$ |  |
| C | 0.23 | 0.32 | L | 0.51 | 1.01 |
| D | 15.20 | 15.40 | R | 0.63 | 0.89 |
| E | 7.40 | 7.60 | ZD | 0.66 REF |  |
| e | 1.27 BSC |  | $\alpha$ | $0^{\circ}$ | $8^{\circ}$ |

Figure 9. PDIP-24 package Diagram


Table 18. PDIP-24 package Dimensions

| Symbol | Min | Typ | Max |  | Symbol | Min |  | Max |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| A |  |  | 4.32 |  | $\mathrm{E}_{1}$ | 6.35 | 6.60 | 6.86 |
| $\mathrm{~A}_{1}$ | 0.380 |  |  |  | $\mathrm{e}_{1}$ | 2.54 BSC |  |  |
| B | 0.38 | 0.46 | 0.56 |  | $\mathrm{e}_{\mathrm{A}}$ | 7.62 BSC |  |  |
| $\mathrm{B}_{1}$ | 1.40 | 1.52 | 1.65 |  | L | 3.18 |  | 3.43 |
| $\mathrm{~b}_{1}$ | 1.14 | 1.27 | 1.40 |  | $\alpha$ | $0^{\circ}$ |  | $15^{\circ}$ |
| C | 0.20 | 0.25 | 0.30 |  | N |  | 24 |  |
| D | 31.62 | 31.75 | 31.88 |  | $\mathrm{Q}_{1}$ | 1.40 | 1.52 | 1.65 |
| E | 7.62 |  | 8.26 |  | $\mathrm{Q}_{2}$ |  | 3.30 |  |
|  |  |  |  |  | S | 1.78 | 1.91 | 2.03 |

## 11 Ordering Information

Table 19. Ordering Information

| Part | Temp Range | Package | Delivery Form |
| :---: | :---: | :---: | :---: |
| AS1100PL | $0^{\circ} \mathrm{C}$ to $+70^{\circ} \mathrm{C}$ | Plastic DIP 24-pin | Tubes |
| AS1100WL | $0^{\circ} \mathrm{C}$ to $+70^{\circ} \mathrm{C}$ | SOIC 24-pin | Tubes |
| AS1100PE | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | Plastic DIP 24-pin | Tubes |
| AS1100WE | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | SOIC 24-pin | Tubes |
| AS1100WL-T | $0^{\circ} \mathrm{C}$ to $+70^{\circ} \mathrm{C}$ | SOIC 24-pin | Tape \& Reel |
| AS1100WE-T | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | SOIC 24-pin | Tape \& Reel |

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